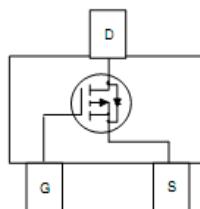
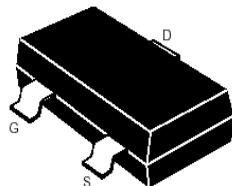


SOT-23**Features**

- Advanced trench process technology
- High Density Cell Design For Ultra Low On-Resistance

**Maximum Ratings & Thermal Characteristics**

(Ratings at 25°C ambient temperature unless otherwise specified.)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	-20	V
Gate-Source Voltage	V <sub>GS</sub>	±12	
Continuous Drain Current	I <sub>D</sub>	-4.1	A
Pulsed Drain Current <sup>1)</sup>	I <sub>DM</sub>	-15	
Maximum Power Dissipation <sup>2)</sup>	P <sub>D</sub>	1.25	W
		0.8	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C
Junction-to-Ambient Thermal Resistance (PCB mounted) <sup>2)</sup>	R <sub>thJA</sub>	100	°C/W
Junction-to-Ambient Thermal Resistance (PCB mounted) <sup>3)</sup>	R <sub>thJA</sub>	166	

## Notes

1) Pulse width limited by maximum junction temperature.

2) Surface Mounted on FR4 Board, t ≤ 5 sec.      3) Surface Mounted on FR4 Board.

**Electrical Characteristics**

(Ratings at 25°C ambient temperature unless otherwise specified).

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = -250μA	-20			V
Drain-Source On-State Resistance <sup>1)</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -4.1A		46	52	mΩ
		V <sub>GS</sub> = -2.5V, I <sub>D</sub> = -3.0A		60	75	
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250μA	0.4		1	V
Zero Gate Voltage Drain Current 0	I <sub>DSS</sub>	V <sub>DS</sub> = -20V, V <sub>GS</sub> = 0V			-1	uA
		V <sub>DS</sub> = -20V, V <sub>GS</sub> = 0V TJ=55°C			-10	
Gate Body Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ±12V, V <sub>DS</sub> = 0V			±100	nA
Forward Transconductance <sup>1)</sup>	g <sub>f</sub>	V <sub>DS</sub> = -5V, I <sub>D</sub> = -3.5A		6.5	—	S
<b>Dynamic</b>						
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> = -6V, I <sub>D</sub> ≈ -3.5A		5.8	10	nC
Gate-Source Charge	Q <sub>gs</sub>			0.85		
Gate-Drain Charge	Q <sub>gd</sub>			1.7		
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = -6V, RL=6Ω I <sub>D</sub> ≈ -1.4A, V <sub>GEN</sub> = -4.5V R <sub>G</sub> = 6Ω		13	25	ns
Turn-On Rise Time	t <sub>r</sub>			36	60	
Turn-Off Delay Time	t <sub>d(off)</sub>			42	70	
Turn-Off Fall Time	t <sub>f</sub>			34	60	
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = -6V, V <sub>GS</sub> = 0V f = 1.0 MHz		415		pF
Output Capacitance	C <sub>oss</sub>			223		
Reverse Transfer Capacitance	C <sub>rss</sub>			87		
<b>Source-Drain Diode</b>						
Max. Diode Forward Current	I <sub>S</sub>				-1.6	A
Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> = -1.6A, V <sub>GS</sub> = 0V		-0.8	-1.2	V

1) Pulse test: pulse width &lt;= 300us, duty cycle &lt;= 2%

### Typical Electrical and Thermal Characteristics

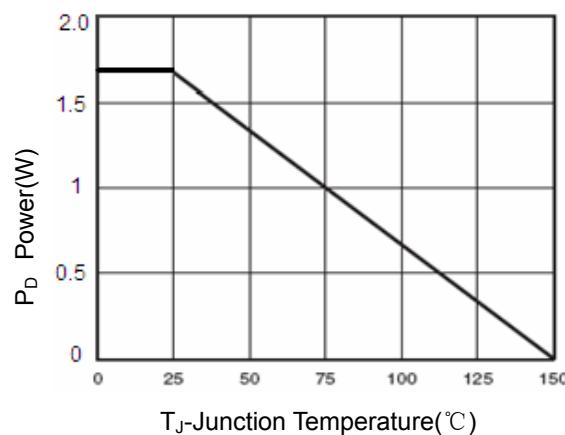


Figure 1 Power Dissipation

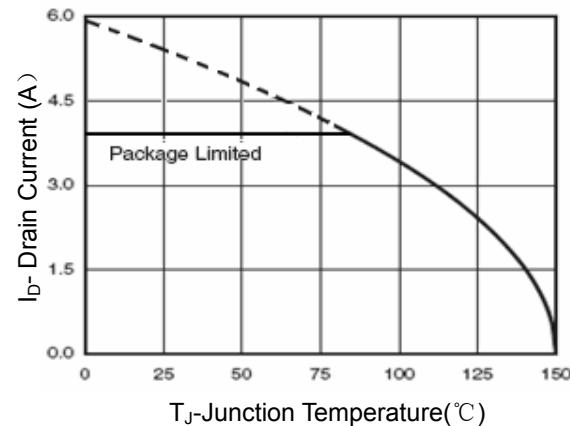


Figure 2 Drain Current

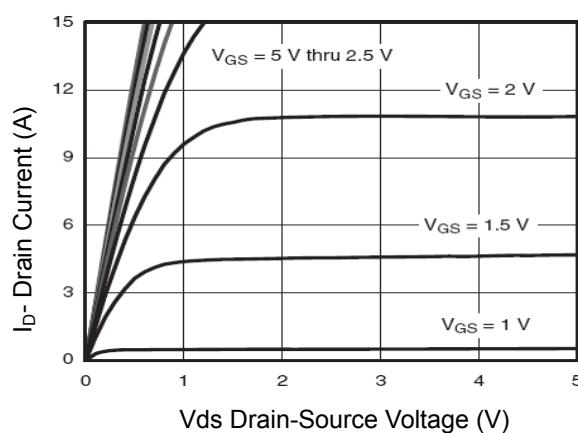


Figure 3 Output Characteristics

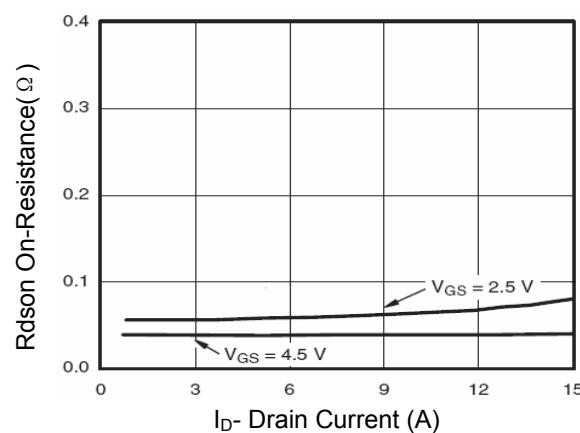


Figure 4 Drain-Source On-Resistance

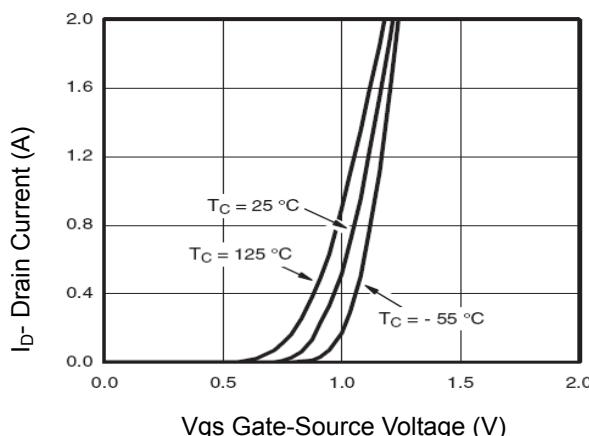


Figure 5 Transfer Characteristics

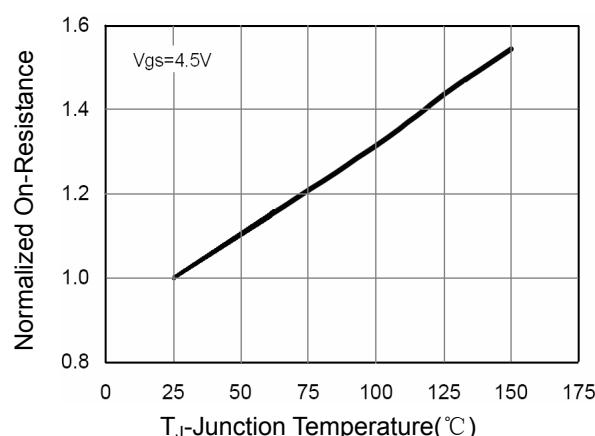


Figure 6 Drain-Source On-Resistance

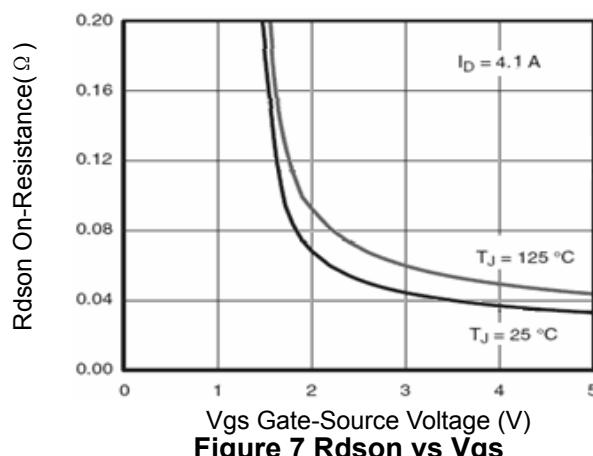


Figure 7 Rdson vs Vgs

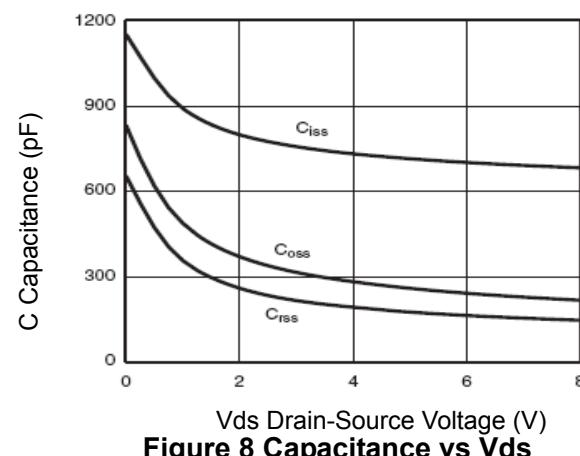


Figure 8 Capacitance vs Vds

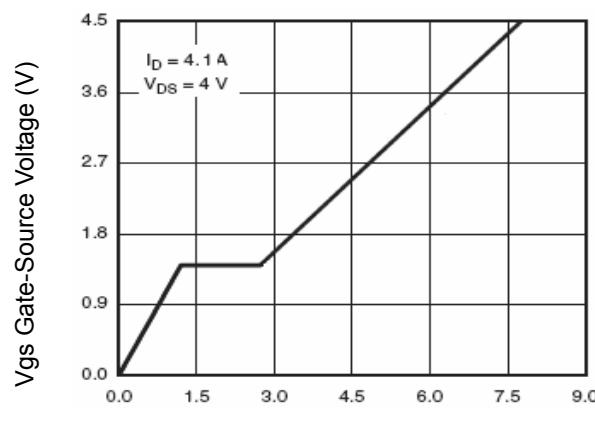


Figure 9 Gate Charge

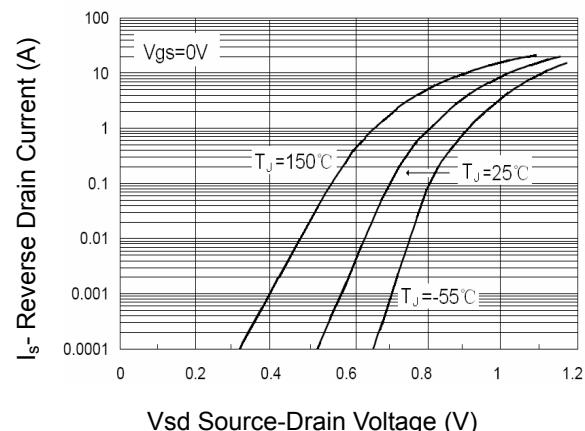


Figure 10 Source- Drain Diode Forward

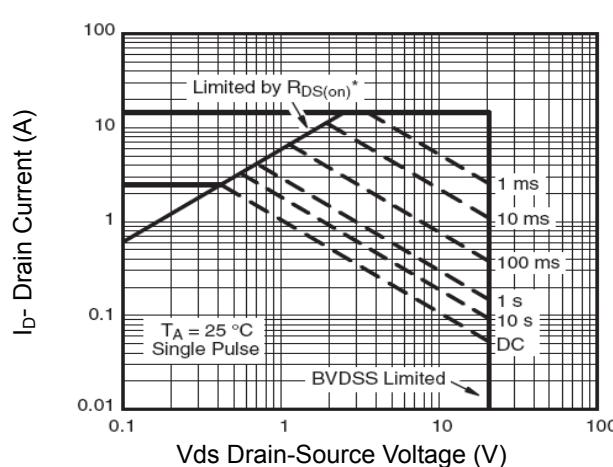
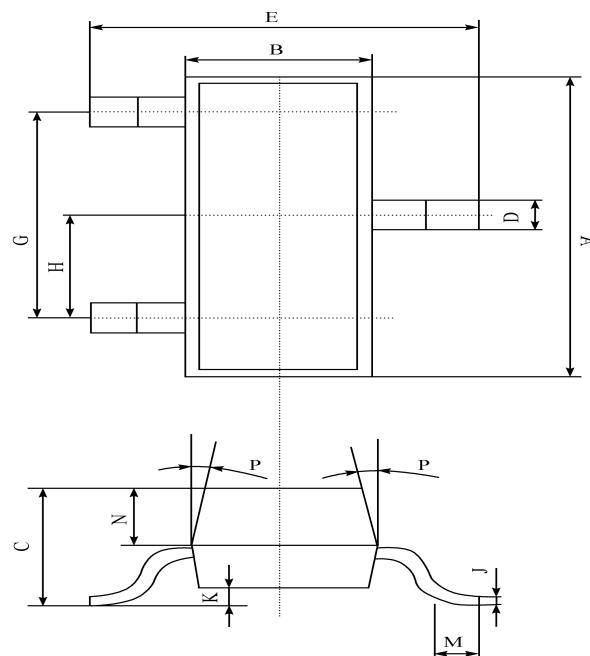


Figure 11 Safe Operation Area

#### SOT-23 PACKAGE OUTLINE Plastic surface mounted package



SOT-23	
A	2.90 ± 0.10
B	1.30 ± 0.10
C	1.00 ± 0.10
D	0.40 ± 0.10
E	2.40 ± 0.20
G	1.90 ± 0.10
H	0.95 ± 0.05
J	0.13 ± 0.05
K	0.00–0.10
M	≥ 0.2
N	0.60 ± 0.10
P	7 ± 2°

(UNIT): mm